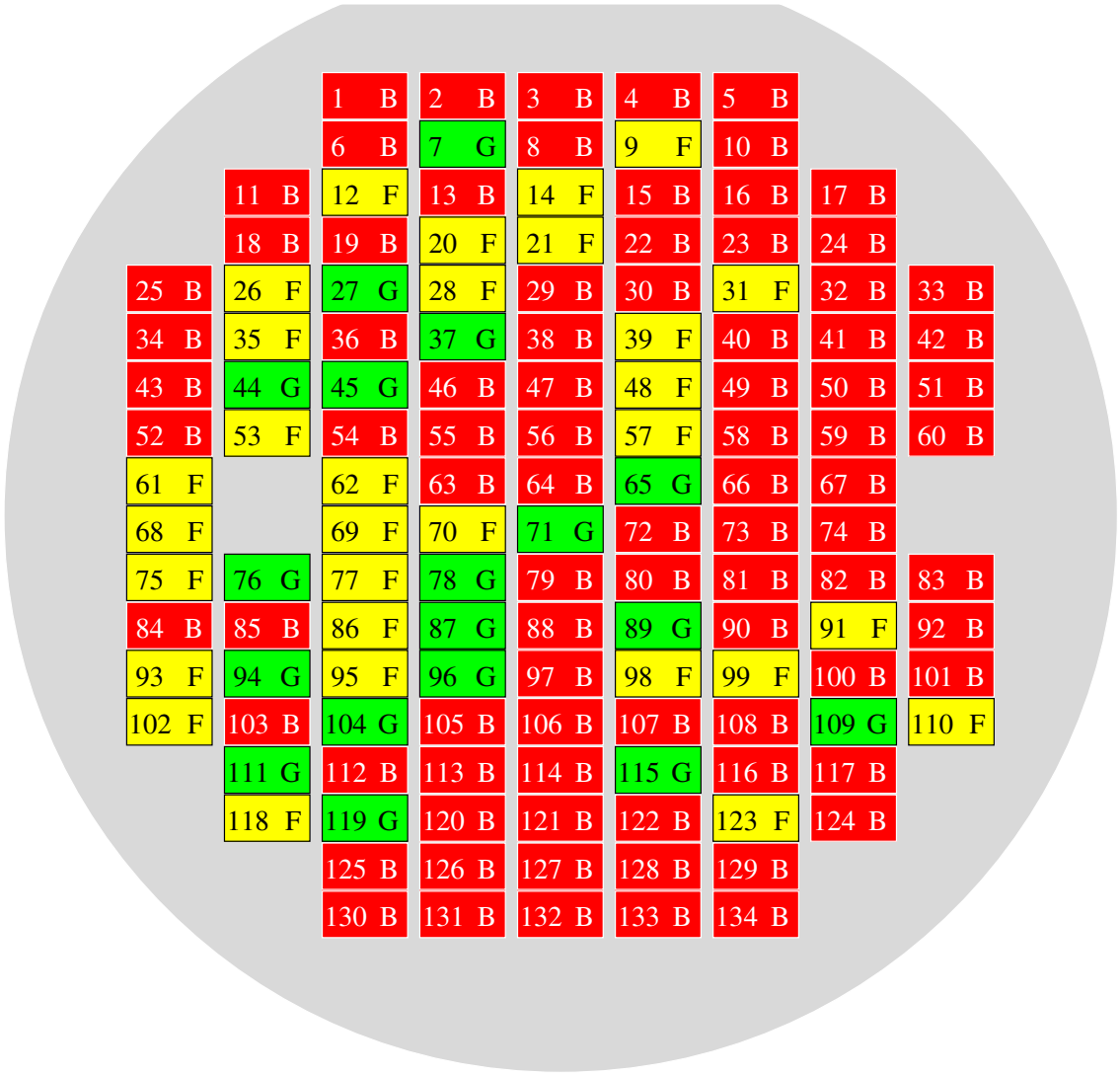
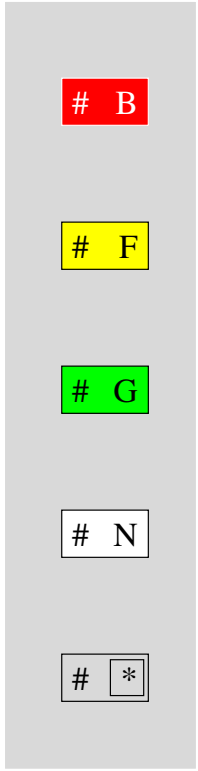
Die quality map for wafer 217 s/n: 21316-15-16

Date: 10/23/99





Bad die

Fair die

Good die

No info

Manually tagged